

SEMICONDUCTOR®

# KST5088/5089

## Low Noise Transistor



KST5088/5089

1. Base 2. Emitter 3. Collector

# **NPN Epitaxial Silicon Transistor**

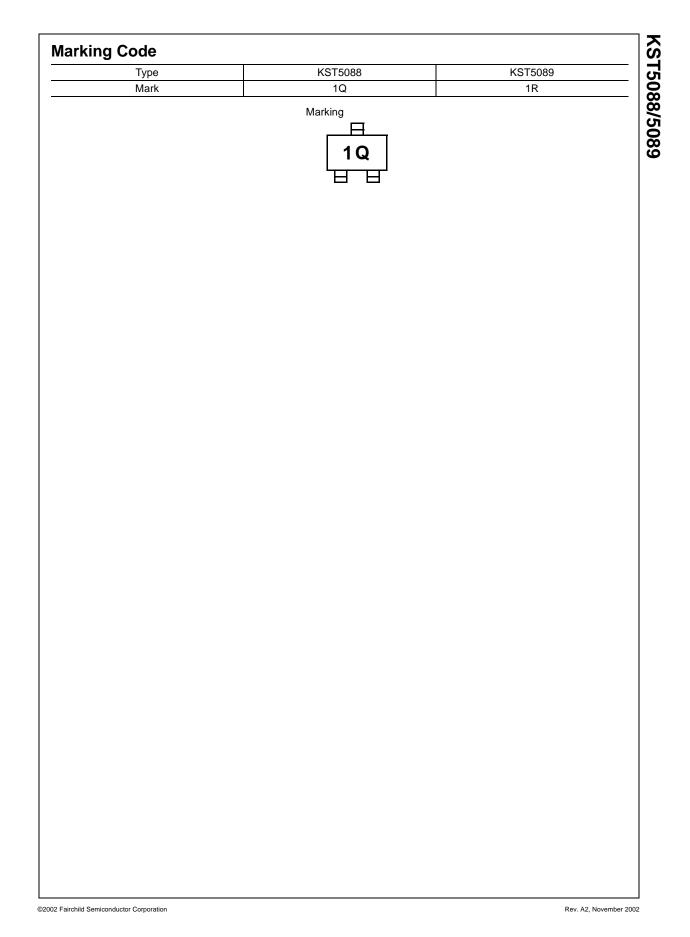
## Absolute Maximum Ratings T<sub>a</sub>=25°C unless otherwise noted

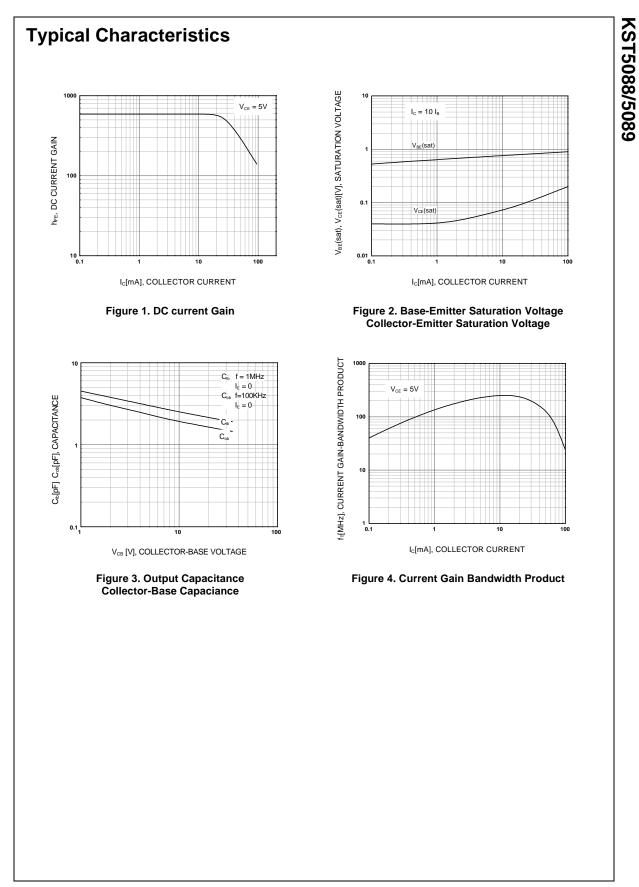
Symbol	Parameter	Value	Units
V <sub>CBO</sub>	Collector-Base Voltage		
020	: KST5088	35	V
	: KST5089	30	V
V <sub>CEO</sub>	Collector-Emitter Voltage		
	: KST5088	30	V
	: KST5089	25	V
V <sub>EBO</sub>	Emitter-Base Voltage	4.5	V
l <sub>c</sub>	Collector Current	50	mA
P <sub>C</sub>	Collector Power Dissipation	350	mW
Т <sub>STG</sub>	Storage Temperature	150	°C

# **Electrical Characteristics** $T_a=25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Max.	Units
BV <sub>CBO</sub>	Collector-Base Breakdown Voltage	I <sub>C</sub> =100μA, I <sub>E</sub> =0			
	: KST5088	-	35		V
	: KST5089		30		V
BV <sub>CEO</sub>	Collector-Emitter Breakdown Voltage	I <sub>C</sub> =1mA, I <sub>B</sub> =0			
	: KST5088	-	30		V
	: KST5089		25		V
I <sub>CBO</sub>	Collector Cut-off Current				
020	: KST5088	V <sub>CB</sub> =20V, I <sub>F</sub> =0		50	nA
	: KST5089	$V_{CB} = 15V, I_{E} = 0$		50	nA
I <sub>EBO</sub>	Emitter Cut-off Current	V <sub>EB</sub> =3V, I <sub>C</sub> =0		50	nA
h <sub>FE</sub>	DC Current Gain				
	: KST5088	V <sub>CE</sub> =5V, I <sub>C</sub> =100μA	300	900	
	:KST5089		400	1,200	
	: KST5088	V <sub>CE</sub> =5V, I <sub>C</sub> =1mA	350		
	: KST5089		450		
	: KST5088	V <sub>CE</sub> =5V, I <sub>C</sub> =10mA	300		
	: KST5089		400		
V <sub>CE</sub> (sat)	Collector-Emitter Saturation Voltage	I <sub>C</sub> =10mA, I <sub>B</sub> =1mA		0.5	V
V <sub>BE</sub> (sat)	Base-Emitter Saturation Voltage	I <sub>C</sub> =10mA, I <sub>B</sub> =1mA		0.8	V
f <sub>T</sub>	Current Gain-Bandwidth Product	V <sub>CE</sub> =5V, I <sub>C</sub> =500µA, f=20MHz	50		MHz
Cob	Output Capacitance	V <sub>CB</sub> =5V, I <sub>E</sub> =0, f=100KHz		4	pF
NF	Noise Figure				
	: KST5088	I <sub>C</sub> =100μA, V <sub>CE</sub> =5V		3	dB
	: KST5089	R <sub>S</sub> =10KΩ, f=10Hz to 15.7KHz		2	dB

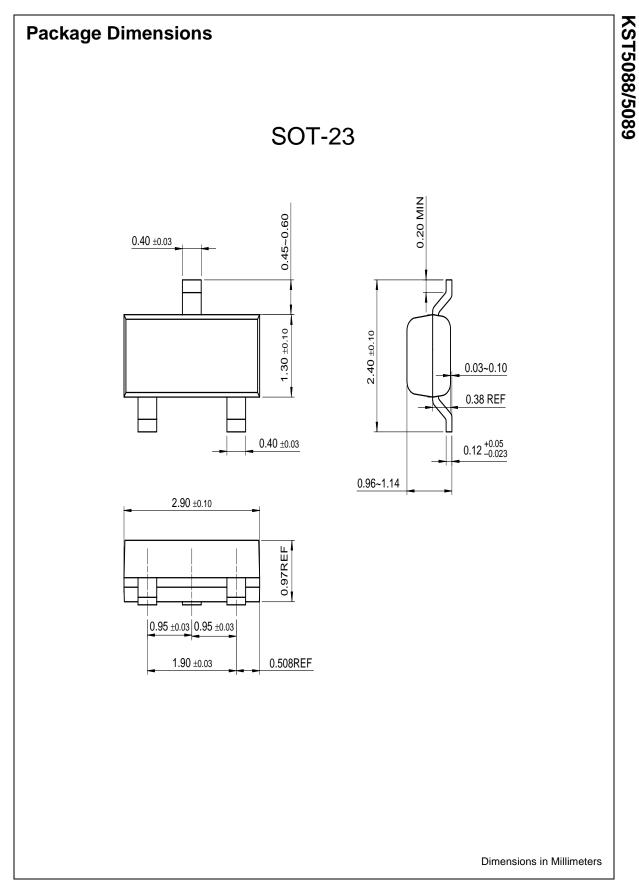
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Programmable Active Droop™	OPTOPLANAR™	SMART START™	

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